

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	09/985,905	LEE, JU HYUN
	Examiner	Art Unit
	Sheela C. Chawan	2625

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
382	125	5/24/2005	SCC
257	98, 103	5/24/2005	SCC
313	506	5/24/2005	SCC